

Features

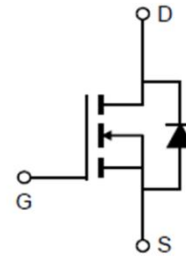
- Uses advanced SGT technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent gate charge x $R_{DS(on)}$ product(FOM)

Application

- Motor control and drives
- Battery management
- DC/DC converter
- General purpose applications

Product Summary

V_{DS}	100V
$R_{DS(on)}@V_{GS}=10V$	4.5mΩ
I_D	109A



Package Marking and Ordering Information

Type	Package	Marking	Reel Size	Tape Width	Qty
LR052N10SML8	DFN5X6	LR052N10SML8	330*16.5mm	12mm	5000

Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	100	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Silicon limit) $T_C = 100^\circ\text{C}$ (Silicon limit)	I_D	109 69	A
Pulsed drain current $T_C = 25^\circ\text{C}$, t_p limited by T_{jmax}	$I_{D \text{ pulse}}$	437	
Avalanche energy, single pulse ($L=0.3\text{mH}$, $R_g=25\Omega$) ⁽¹⁾	E_{AS}	166	mJ
Gate-Source voltage	V_{GS}	±20	V
Power dissipation $T_C = 25^\circ\text{C}$	P_D	125	W
Operating junction and storage temperature	T_j, T_{stg}	-55~150	°C

Notes:

(1) $V_{DS}=50V, V_{GS}=10V, L=0.3\text{mH}$

Thermal Resistance

	Symbol	Value	Unit
Thermal resistance, junction – case. Max	R_{thJC}	1.0	°C/W

Electrical Characteristic, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Test Condition	Value			Unit
			min.	typ.	max.	

Static Characteristic

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	100	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$ $T_j=25^\circ C$	1.3	1.9	2.5	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=100V, V_{GS}=0V$ $T_j=25^\circ C$	-	-	1	μA
Gate-source leakage current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=40A,$ $T_j=25^\circ C$	-	4.5	5.2	mΩ
Transconductance	g_{fs}	$V_{DS}=5V, I_D=40A$	-	88	-	S

Dynamic Characteristic

Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=50V,$ $f=1MHz$	-	3100	-	pF
Output Capacitance	C_{oss}		-	430	-	
Reverse Transfer Capacitance	C_{rss}		-	19	-	
Gate Total Charge	Q_G	$V_{GS}=10V, V_{DS}=50V,$ $I_D=40A$	-	60	-	nC
Gate-Source charge	Q_{gs}		-	10	-	
Gate-Drain charge	Q_{gd}		-	17	-	
Turn-on delay time	$t_{d(on)}$	$I_D=40A, V_{GS}=10V,$ $V_{DD}=50V, R_G=3.0\Omega$	-	14	-	ns
Rise time	t_r		-	74.3	-	
Turn-off delay time	$t_{d(off)}$		-	42	-	
Fall time	t_f		-	110	-	
Gate resistance	R_G	$V_{GS}=0V, V_{DS}=0V,$ $f=1MHz$	-	2	-	Ω

Body Diode Characteristic

Body Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_F=40A$	-	0.9	1.1	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F=40A,$ $dI/dt=100A/\mu s$	-	52	-	ns
Body Diode Reverse Recovery Charge	Q_{rr}	$I_F=40A,$ $dI/dt=100A/\mu s$	-	21	-	nC

Typical Performance Characteristics

Fig 1: Output Characteristics

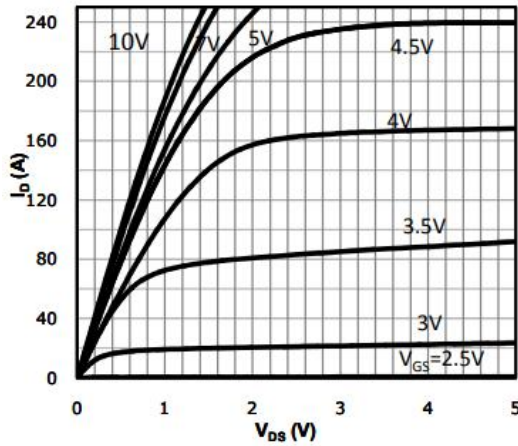


Fig 2: Transfer Characteristics

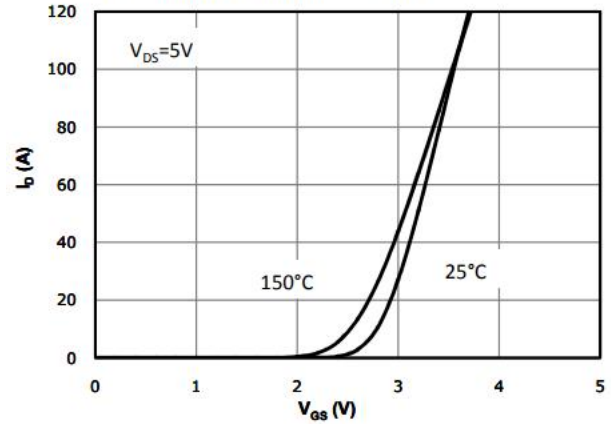


Fig 3: $R_{DS(on)}$ vs Drain Current and Gate Voltage

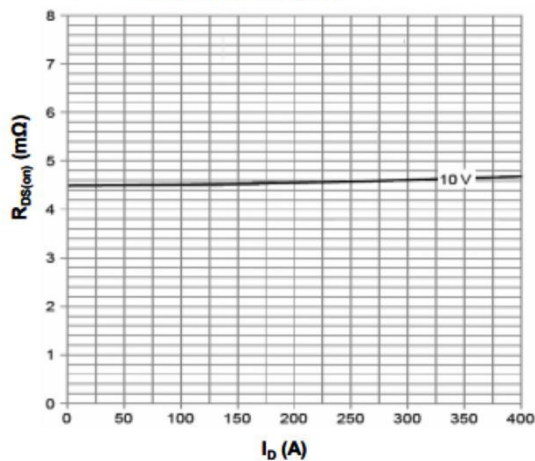


Fig 4: $R_{DS(on)}$ vs Gate Voltage

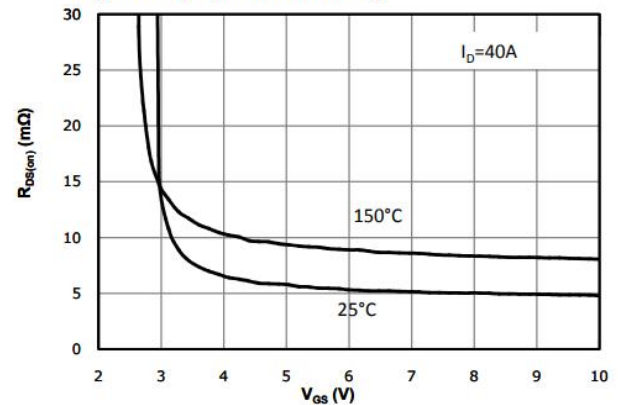


Fig 5: $R_{DS(on)}$ vs. Temperature

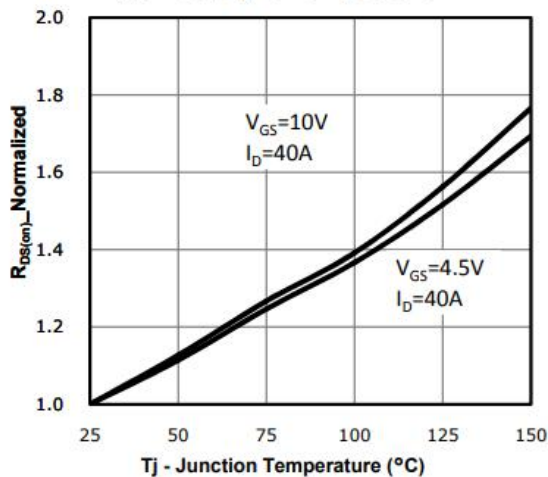


Fig 6: Capacitance Characteristics

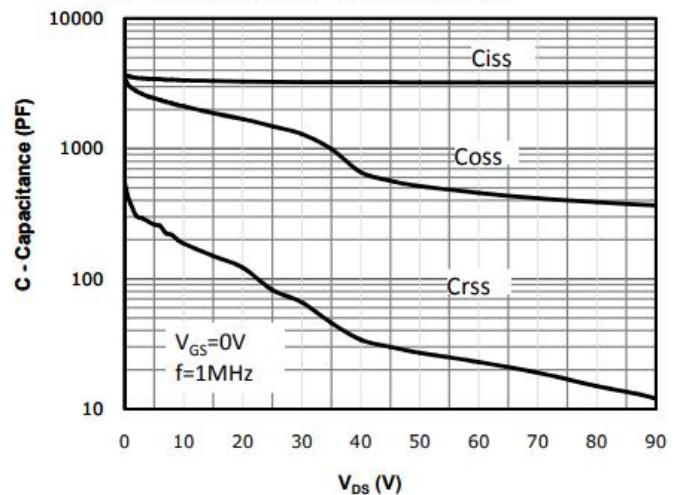


Fig 7: Gate Charge Characteristics

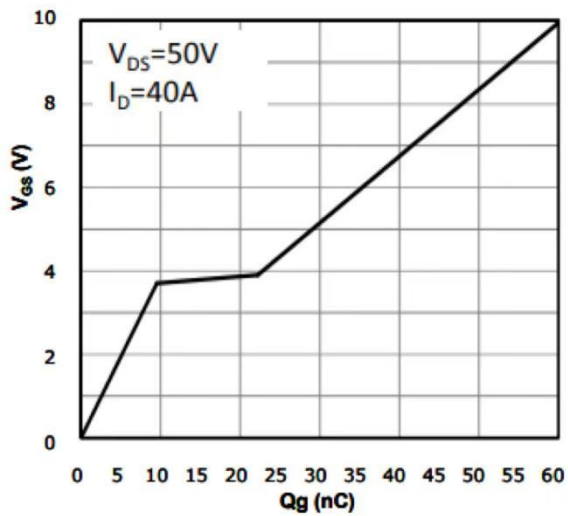


Fig 8: Body-diode Forward Characteristics

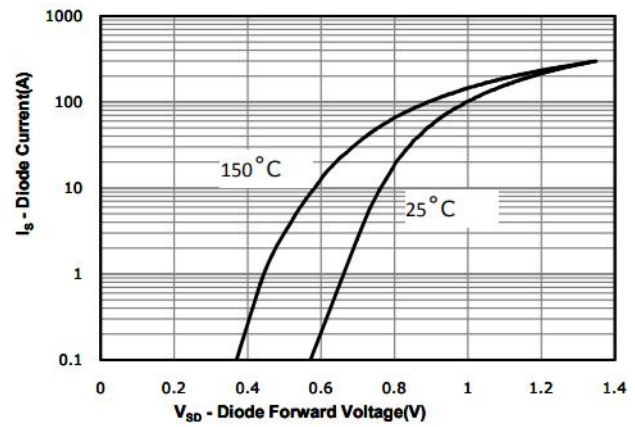


Fig 9: Power Dissipation

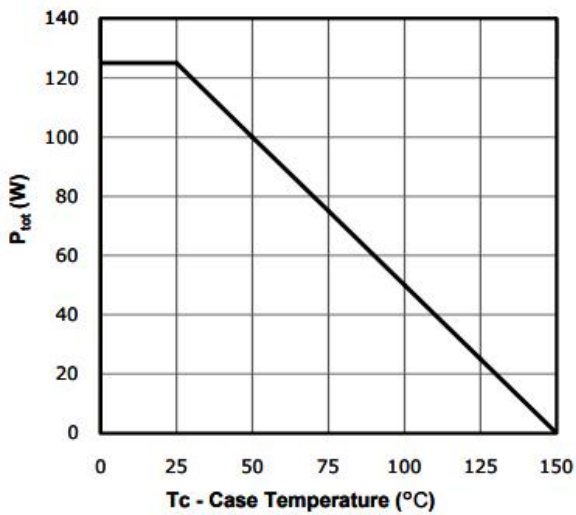


Fig 10: Drain Current Derating

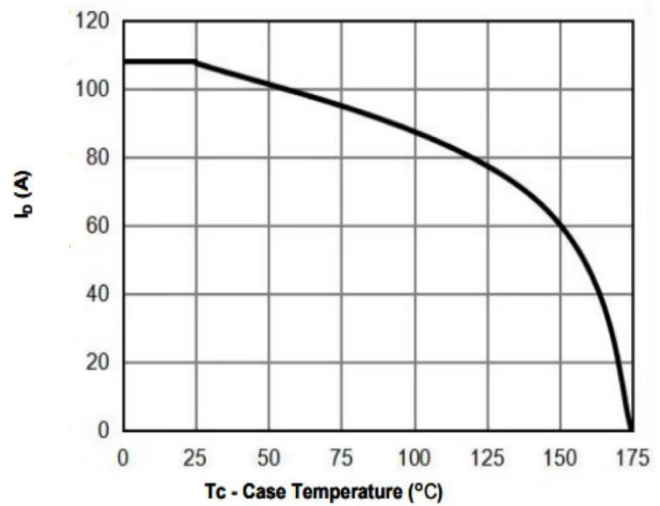


Fig 11: Safe Operating Area

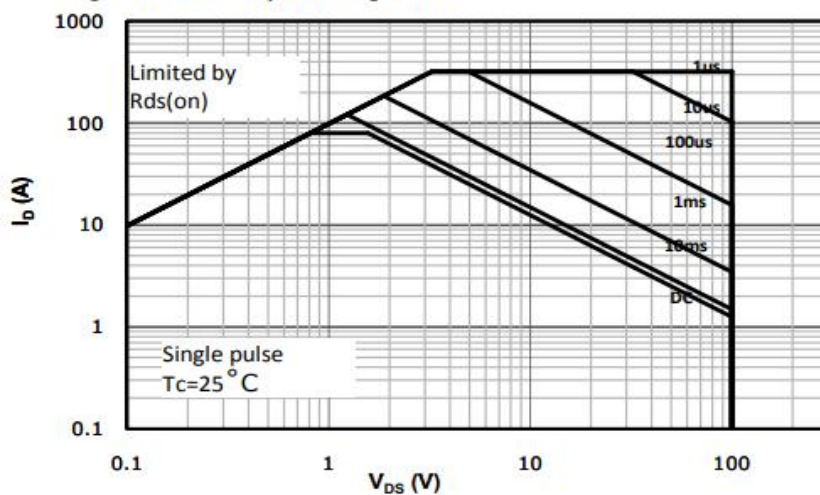
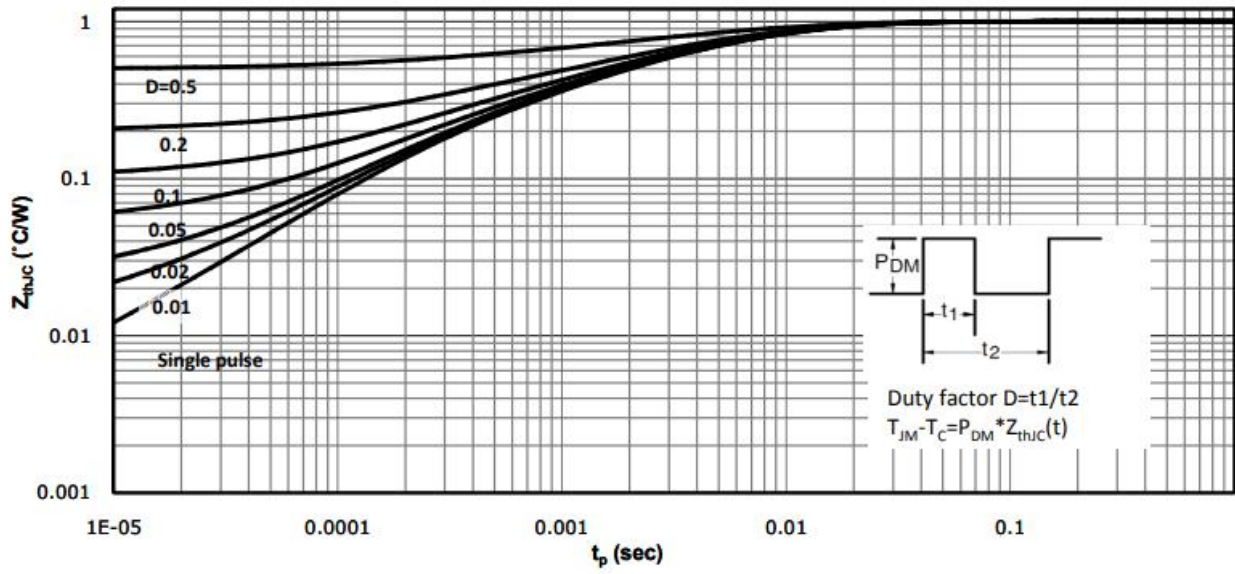
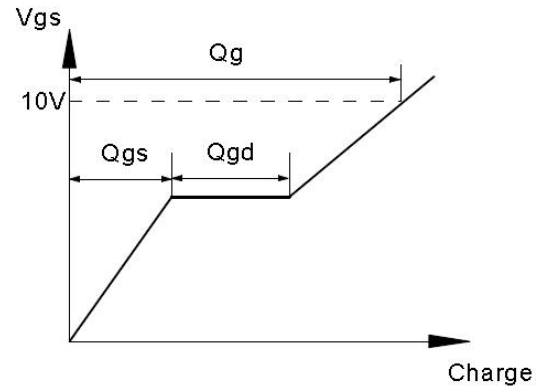
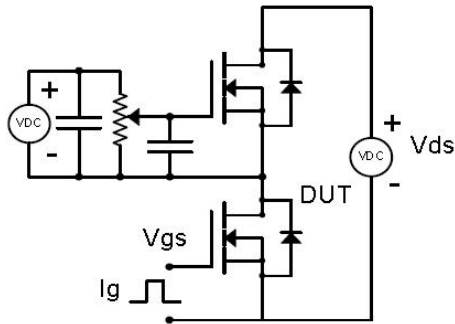


Fig 12: Max. Transient Thermal Impedance

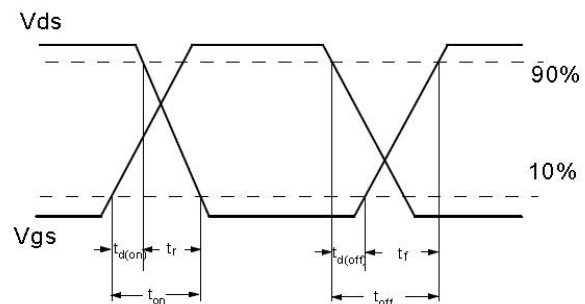
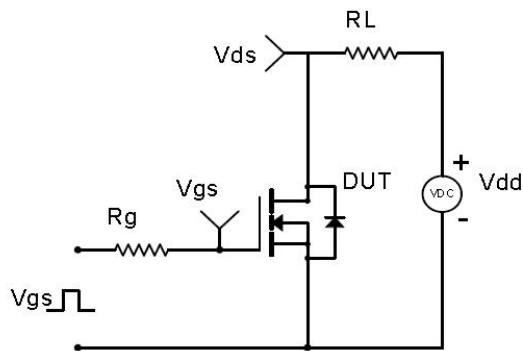


Test Circuit & Waveform

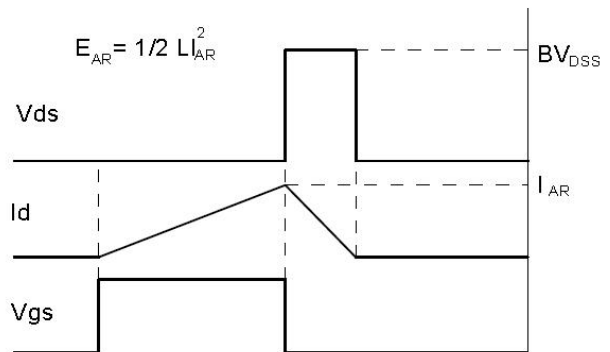
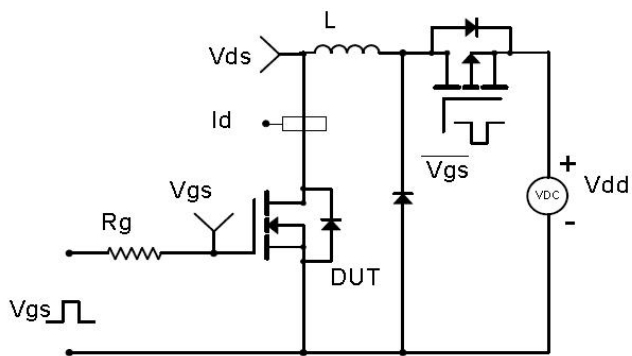
Gate Charge Test Circuit & Waveform



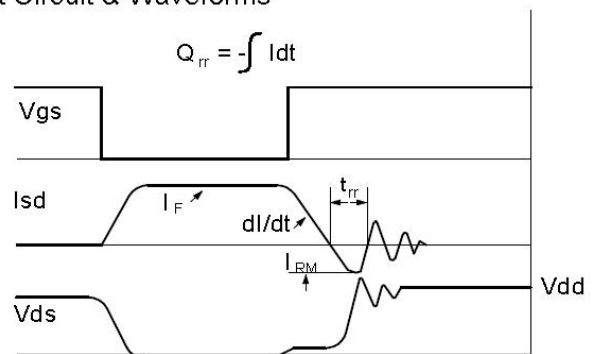
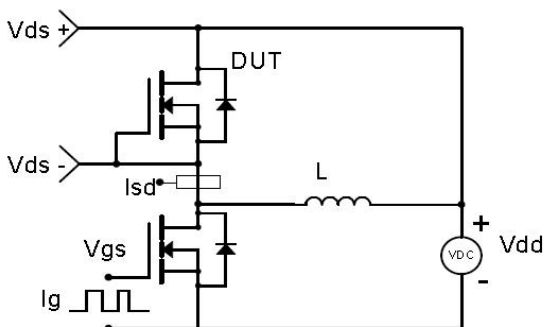
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: DFN5X6

